

ON Semiconductor[®]

FDN5630

60V N-Channel PowerTrench® MOSFET

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

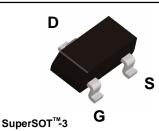
This MOSFET features very low R_{DS(ON)} in a small SOT23 footprint. ON Semiconductor's PowerTrench technology provides faster switching than other MOSFETs with comparable R_{DS(ON)} specifications. The result is higher overall efficiency with less board space.

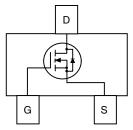
Features

- 1.7 A, 60 V. $R_{DS(ON)} = 0.100 \ \Omega \ @ V_{GS} = 10 \ V$ $R_{DS(ON)} = 0.120 \ \Omega \ @ V_{GS} = 6 \ V.$
- Optimized for use in high frequency DC/DC converters.
- Low gate charge.
- Very fast switching.
- SuperSOT[™] 3 provides low R_{DS(ON)} in SOT23 footprint.

Applications

- DC/DC converter
- Motor drives





Absolute Maximum Ratings T_A = 25 C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		60	V
V _{GSS}	Gate-Source Voltage		±20	V
ID	Drain Current - Continuous	(Note 1a)	1.7	A
	- Pulsed		10	7
P _D	Power Dissipation for Single Operation	(Note 1a)	0.5	W
		(Note 1b)	0.46	7
T _J , T _{stg}	Operating and Storage Junction Temperatur	re Range	-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	250	°C/W
$R_{_{\!\!\!\!\Theta}JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	75	°C/W

Package Marking and Ordering Information

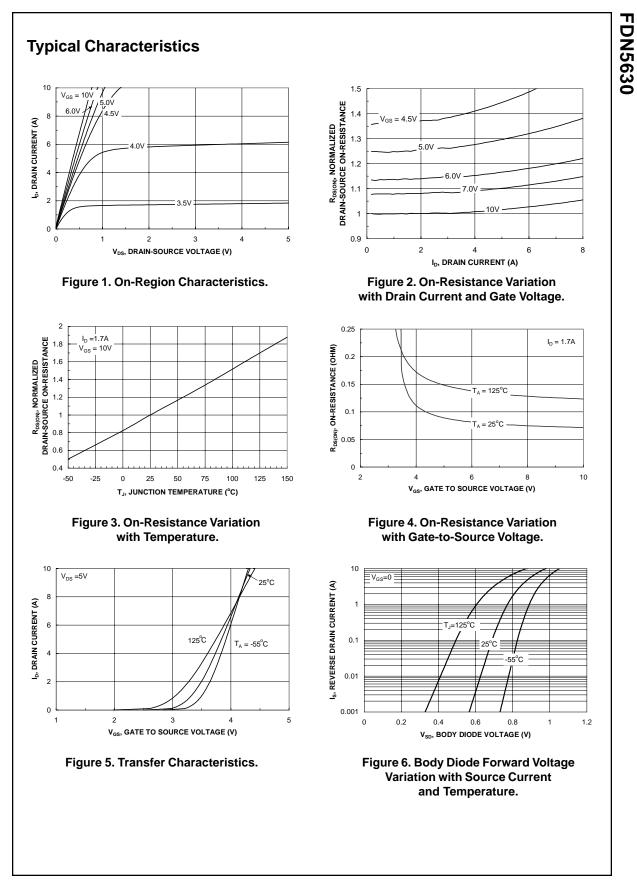
Device Marking	Device	Reel Size	Tape Width	Quantity
5630	FDN5630	7	8mm	3000 units

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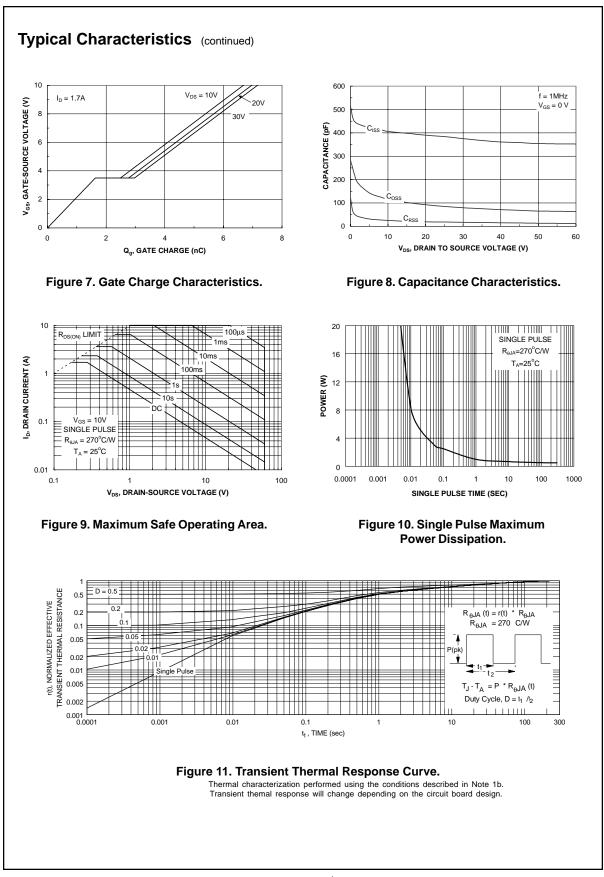
FDN5630

	Test Conditions	Min	Тур	Max	Units
cteristics					
Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60	1		V
Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}, \text{Referenced to } 25^\circ\text{C}$		63		mV/°C
Zero Gate Voltage Drain Current	$V_{DS} = 48 V, V_{GS} = 0 V$			1	μA
Gate-Body Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
Gate-Body Leakage Current, Reverse	$V_{GS} = -20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
cteristics (Note 2)					
Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1	2.4	3	V
Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}, \text{Referenced to } 25^\circ\text{C}$		-6.9		mV/°C
Static Drain-Source On-Resistance	$ \begin{array}{c} V_{GS} = 10 \; V, \; I_D = 1.7 \; A \\ V_{GS} = 10 \; V, \; I_D = 1.7 \; A, \; T_J = 125^\circ C \\ V_{GS} = 6 \; V, \; I_D = 1.6 \; A \end{array} $		0.073 0.127 0.083	0.100 0.180 0.120	Ω
On-State Drain Current	$V_{GS} = 10 \text{ V}, \text{ V}_{DS} = 1.7 \text{ V}$	5			A
Forward Transconductance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1.7 \text{ A}$		6		S
Characteristics					
Input Capacitance	$V_{DS} = 15 V, V_{GS} = 0 V,$	Ī	400	560	pF
Output Capacitance	f = 1.0 MHz		65	95	pF
Reverse Transfer Capacitance	-			40	pF
	_				
	$V_{} = 30 V I_{} = 1 A$	1	10	20	ns
•	$V_{\text{DD}} = 30 \text{ V}, \text{ ID} = 1 \text{ A},$ $V_{\text{GS}} = 10 \text{ V}, \text{ R}_{\text{GEN}} = 6 \Omega$				ns
	-		-		ns
	-				
	$1/_{-2} = 20 1/_{-2} = 1.7 $				ns nC
	$V_{DS} = 20 V, I_D = 1.7 A,$ $V_{GS} = 10 V,$			10	
*					nC
Gate-Drain Charge			1.2		nC
				0.42	A
	$V_{GS} = 0 \text{ V}, \text{ I}_{S} = 0.42 \text{ A}$ (Note 2)		0.72	1.2	V
of the junction-to-case and case-to-ambient therma		ined as the	solder mour	nting	ļ
a) 250°C/W when b mounted on a 0.02 in ² Pad of 2 oz. Cu.	 p) 270°C/W when mounted on a minimum pad. 				
	Drain-Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate-Body Leakage Current, Forward Gate-Body Leakage Current, Reverse Cteristics (Note 2) Gate Threshold Voltage Con-Resistance On-State Drain Current Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Characteristics (Note 2) Turn-On Delay Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Drain Charge Ince Diode Characteristics a Maximum Continuous Drain-Source Drain-Source Diode Forward Voltage	Drain-Source Breakdown Voltage $V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$ Breakdown Voltage Temperature CoefficientI_D = 250 \mu\text{A}, Referenced to 25°CZero Gate Voltage Drain Current $V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}$ Gate-Body Leakage Current, Forward $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$ Gate-Body Leakage Current, Reverse $V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$ Cteristics (Note 2)(Note 2)Gate Threshold Voltage $V_{DS} = V_{GS}, \text{ I}_D = 250 \mu\text{A}$ Gate Threshold VoltageI_D = 250 \mu\text{A}, Referenced to 25°CTemperature CoefficientI_D = 250 \mu\text{A}, Referenced to 25°CStatic Drain-Source $V_{GS} = 10 \text{ V}, \text{ I}_D = 1.7 \text{ A}$ On-Resistance $V_{GS} = 10 \text{ V}, \text{ I}_D = 1.7 \text{ A}$ On-State Drain Current $V_{GS} = 10 \text{ V}, \text{ V}_D = 1.7 \text{ A}$ Forward Transconductance $V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ f} = 1.0 \text{ MHz}$ Input Capacitance $V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ f} = 1.0 \text{ MHz}$ Turn-On Delay Time $V_{DD} = 30 \text{ V}, \text{ I}_D = 1.7 \text{ A}, \text{ V}_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ Turn-Off Delay Time $V_{DS} = 20 \text{ V}, \text{ I}_D = 1.7 \text{ A}, \text{ V}_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ Turn-Off Delay Time $V_{DS} = 20 \text{ V}, \text{ I}_D = 1.7 \text{ A}, \text{ V}_{GS} = 10 \text{ V}, \text{ G}_S =$	Drain-Source Breakdown Voltage $V_{GS} = 0 V, I_D = 250 \mu A$ 60 Breakdown Voltage Temperature Coefficient $I_D = 250 \mu A, Referenced to 25^{\circ}C$ 0 Zaro Gate Voltage Drain Current $V_{GS} = 48 V, V_{GS} = 0 V$ 0 Gate-Body Leakage Current, Forward $V_{GS} = 20 V, V_{DS} = 0 V$ 0 Gate-Body Leakage Current, Reverse $V_{GS} = -20 V, V_{DS} = 0 V$ 1 Gate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250 \mu A$ 1 Gate Threshold Voltage $I_D = 250 \mu A, Referenced to 25^{\circ}C$ 1 Gate Threshold Voltage $I_D = 250 \mu A, Referenced to 25^{\circ}C$ 1 Gate Threshold Voltage $I_D = 250 \mu A, Referenced to 25^{\circ}C$ 1 Gate Threshold Voltage $I_D = 1.7 A, T_J = 125^{\circ}C$ $V_{GS} = 10 V, I_D = 1.7 A$ On-State Drain Current $V_{GS} = 10 V, I_D = 1.7 A$ 1 Output Capacitance $V_{DS} = 15 V, V_{GS} = 0 V, f$ 1 Input Capacitance $V_{DS} = 10 V, I_D = 1.4 A, V_{GS} = 10 V, R_{GEN} = 6 \Omega$ 1 Turn-On Delay Time $V_{DS} = 20 V, I_D = 1.7 A, V_{GS} = 10 V, GS = 10 V, R_{GEN} = 6 \Omega$ 1 Turn-On fise Time $V_{DS} = 20 V, I_D = 1.7 A, V_{GS} = 10 V, GS = 10 $	Drain-Source Breakdown Voltage $V_{GS} = 0 V$, $I_D = 250 \mu A$, Referenced to 25°C 60 Breakdown Voltage Temperature Coefficient $I_D = 250 \mu A$, Referenced to 25°C 63 Zero Gate Voltage Drain Current, Forward $V_{DS} = 48 V$, $V_{GS} = 0 V$ 63 Gate-Body Leakage Current, Forward $V_{GS} = -20 V$, $V_{DS} = 0 V$ 63 Gate-Body Leakage Current, Forward $V_{GS} = -20 V$, $V_{DS} = 0 V$ 64 Gate-Body Leakage Current, Forward $V_{GS} = -20 V$, $V_{DS} = 0 V$ 64 Gate Threshold Voltage $V_{DS} = 48 V$, $V_{GS} = 0 V$, $V_{DS} = 0 V$ 64 Gate Threshold Voltage $V_{DS} = -250 \mu A$, Referenced to 25°C -6.9 Temperature Coefficient $I_D = 250 \mu A$, Referenced to 25°C -6.9 Static Drain-Source $V_{GS} = 10 V$, $I_D = 1.7 A$, $T_J = 125°C$ 0.073 On-Resistance $V_{DS} = 10 V$, $I_D = 1.7 A$ 6 Characteristics Input Capacitance $V_{DS} = 10 V$, $I_D = 1.7 A$ 6 Characteristics Input Capacitance $V_{DS} = 10 V$, $I_D = 1.7 A$ 6 Characteristics (Note 2) 10 V, $I_D = 1 A$, $V_{CS} = 0 V$, $I_D = 1 A$, $V_{CS} = 10 V$, $R_{CS} = 10 $	Drain-Source Breakdown Voltage $V_{GS} = 0 V$, $I_D = 250 \mu A$ 60 Breakdown Voltage Temperature $I_D = 250 \mu A$, Referenced to 25°C 63 Zero Gate Voltage Drain Current $V_{DS} = 48 V$, $V_{GS} = 0 V$ 10 Gate-Body Leakage Current, $V_{GS} = 20 V$, $V_{DS} = 0 V$ -100 Reverse $V_{GS} = -20 V$, $V_{DS} = 0 V$ -100 Reverse $V_{GS} = -20 V$, $V_{DS} = 0 V$ -100 Reverse $V_{GS} = -20 V$, $V_{DS} = 0 V$ -100 Reverse $V_{GS} = -20 V$, $V_{DS} = 0 V$ -100 Reverse $V_{GS} = -20 V$, $V_{DS} = 0 V$ -100 Reverse $V_{GS} = -20 V$, $V_{DS} = 0 V$ -100 Reverse $V_{GS} = -20 V$, $V_{DS} = 0 V$ -100 Reverse $V_{GS} = -20 V$, $V_{DS} = 0 V$ -100 Reverse $V_{GS} = -20 V$, $V_{DS} = 0 V$ -100 Reverse $V_{GS} = 10 V$, $I_D = 1.7 A$ -10 Reverse $V_{GS} = 10 V$, $I_D = 1.7 A$, $T_J = 125^{\circ}C$ -16.9 Temperature Coefficient $V_{GS} = 10 V$, $V_{DS} = 1.7 V$ -5 Forward Transconductance $V_{DS} = 10 V$, $V_{DS} = 1.7 V$ -5 Forward Transconductance $V_{DS} = 10 V$, $V_{DS} = 1.7 V$ -5 Forward Transconductance $V_{DS} = 10 V$, $V_{DS} = 1.7 V$ -5 Reverse Transfer Capacitance $I_{SS} = 10 V$, $V_{DS} = 1.7 V$ -5 Turn-On Rise Time $V_{DS} = 10 V$, $V_{DS} = 0 V$, $I_{DO} = 500$ Turn-On Rise Time $V_{CS} = 10 V$, $V_{CS} = 0 V$, $I_{OO} = 500$ Turn-On Rise Time $V_{CS} = 10 V$, $V_{CS} = 0 V$, $I_{OO} = 500$ Turn-On Rise Time $V_{CS} = 10 V$, $R_{GEN} = 6 \Omega$ -6 To 20 Turn-On Rise Time $V_{CS} = 10 V$, $R_{GEN} = 6 \Omega$ -6 To 20 Turn-On Rise Time $V_{CS} = 10 V$, $R_{GEN} = 6 \Omega$ -7 Total Gate Characteristics and Maximum Ratings Maximum Continuous Drain-Source Diode Forward Current -1 Ture Diode Characteristics and Maximum Ratings Train-Source Diode Forward $V_{GS} = 0 V$, $I_S = 0.42 A$ (Note 2) 0.72 1.2 Voltage $V_{CS} = 0 V$, $I_S = 0.42 A$ (Note 2) 0.72 1.2 Voltage $V_{CS} = 0 V$, $I_S = 0.42 A$ (Note 2) 0.72 1.2 Voltage $V_{CS} = 0 V$, $I_S 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